

<b>Notice of References Cited</b>	Application/Control No. 10/660,655	Applicant(s)/Patent Under Reexamination GEUM, CHANG-SEOK	
	Examiner Briget P. Ngampa	Art Unit 1792	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,391,378	05-2002	Carr et al.	427/8
*	B	US-6,001,203	12-1999	Yamada et al.	156/106
*	C	US-6,455,099	09-2002	Enchi et al.	427/96.2
*	D	US-5,409,545	04-1995	Levey et al.	134/22.18
*	E	US-6,139,639	10-2000	Kitamura et al.	118/680
*	F	US-6,595,819	07-2003	Kitahara et al.	445/24
*	G	US-5,431,771	07-1995	Vinouze et al.	216/23
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO/0011710	03-2000	WO	Enchi et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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